

Notice of References Cited	Application/Control No. 09/987,477	Applicant(s)/Patent Under Reexamination OHTAKE ET AL.	
	Examiner A. Sefer	Art Unit 2826	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,630,974	10-2003	Galabova et al.	349/119
*	B	US-2003/0147030	08-2003	Sone, Takehiko	349/113
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	F	US-			
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	K	US-			
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	M	US-			

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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